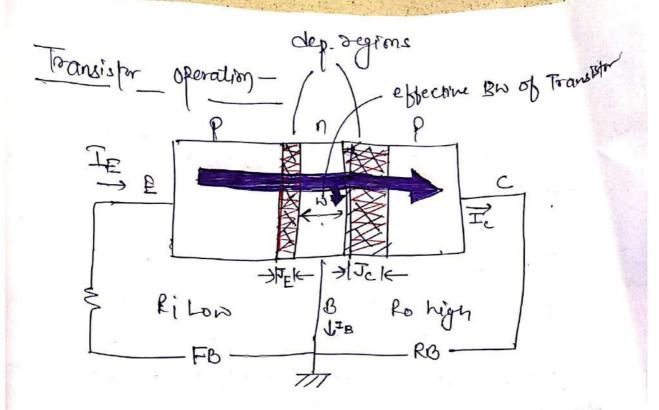
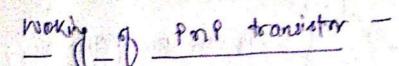


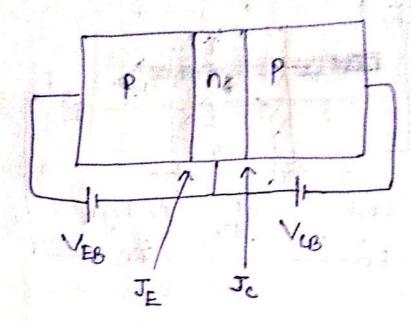
- Emitter is highly doped to igents maximum no of change carrious to sase. Base is lightly doed to reduce the recombination. & thus Ic Coollector Current). So Dolling of E>c>B Collector is provided with largest area to reduce heat descipation in the willow with -) Base with smallest area to reduce transit time (time taken by change carrier to morty fram F - to c) so for Area, C>E>B-Low jo resistance. with a ci whereast wif-High sofp secretance. of (white in) 22 p apple 200 Bipolar device (Because majority & minority both are sesponsible for Conduction) -) Noisy device due to presence of minority change + Leakage current exist of theorfor temp. affects on the device. - major application as amps Camplifier).



- The widths of dep layer, indicating clearly which junction is FB & which is RB.
- → A large no of maj charge carrier will diffuse across the FB P-n junction into n type material.
- Since the sandwiched n layer is very thin of has law conductivity (less doping), a very small no of change carrier will recombine with base (at base) results IB.
- And now after crossing JE, majority change carrier of player (i.e holes) became minority at n layer (holes are minority for n layer sc).

  And now for minority there is no restriction
- for minosity even in R.B.
  go they will cross Je Greachs at collector





- As holes are majority charge carrier in P(Emitter layer) & pn jn (i.e JE) is in FB 20 & ep holes to Emitter will be repel by VEB.

  So they will flow towards JE. This considers the Emitter current IE.
- As heles Combine with e of base besse is lightly depend so only few notes (less than 5%)

  Bus Combine with e. This Consistutes the Base Current Is.
- But there are minerity in Base 20 they (holes)

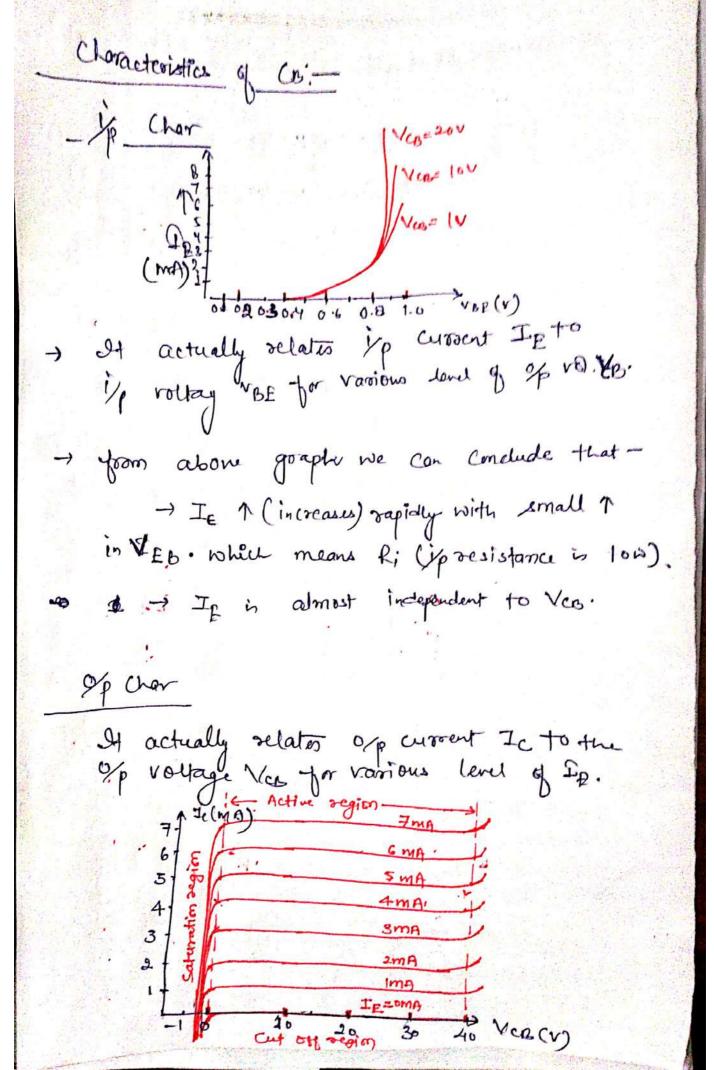
  Cross Jc & seaches Collector Consider Ic.
- -> So, basilly me are controlling current byo & & C by appling proper IB.

Scanned with CamScanner

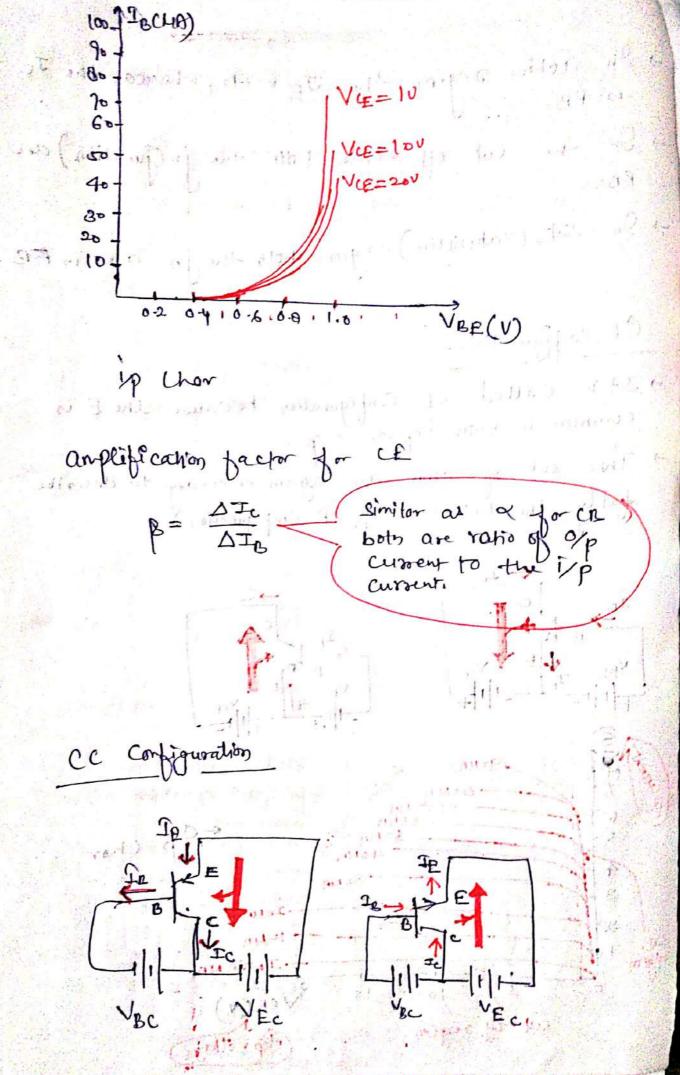
i) Common Base Configuration
Here ip is applied b/s (between)  Emitter (P) & Base (B) & O/p is taken 30/10  B & Collection
ouchar(c).
Circuit.
VPE Noce VCC
a CB (Common Base) hon roansister (11) shows
in figure (9) of co, pnp to in figure).
Current amplification factor  Where DIC=  Where DIC=  Change in Ic  SE= chappin  Where DIC=  Change in Ic  SE= chappin  Where to the ip  Where to the ip  Current &
On case of UB, It is if current of
It is of current.

Scanned with CamScanner

Expression for collection current --) As we all know whole Ip does't the collector. Because some of its prentifice at bose region due to ce-tide recombination gives gise to base current. Since the Jc is RB so a leakage current minori will also flow from & c to B (sue to majority) 80, from abone disscussion it is clear, → IE = IB+ Ic Some of Emitter
Charge Carrier
Charge Carrier
The Charge Carrier
of E which remain
after recombination. I =  $\alpha I_E + I_{CBO}$  — 2 Meakage current due to minosity charge carrier. 1 pm - agh 0 40 Ic= ~ (Ic+[B) + IcBO 2(1-x) = x IB + IcBo Ic2 ( - ~ ) IL+ (1-~ ) Icso



In active region the JE is FB, whereas the Jc is RB. I In the Cut top region both the j'n (junction) are RB. - In Sato (Saturation) Degion both the jo age in FB. 1.1 - DA A O I + U & CE Configuration. 7 It is called CE Configuration because the E is Common in both ip & op. Two set of char are again necessary to describe fully the behaviour of CE Configuration. ← Ic I Mampifo cut of region



- The third & final configuration is cc.
  - Collector is connected in some manner as limitter, so from design point of view there is no need of set of ce char.
  - -> It can be designed wing CE configuration.
  - of the cc configuration are same as CF.
  - In sage of IB.
  - -> the yp cher will be plot of IBVS VBC.

Anglification Juston 
Y= ATE

DIB

\_\_\_ Chapter Over\_\_\_\_

H.W

amplification bactor of us, CE &cc (i.e. selation b/w &, B&r).

